

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10581470	LERCHE, THOMAS
<b>Examiner</b>	<b>Art Unit</b>	
Patrick F O'Reilly III	3749	

<b>SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
454	75, 76, 258	3/10/2008	PFO3
236	49.5	3/10/2008	PFO3

<b>SEARCH NOTES</b>			
<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>	
EAST (USPAT, US-PGPUB, USOCR, EPO, JPO DERWENT, IBM_TDB) searched - printout attached.	3/9/2008; 3/10/2008	PFO3	
PLUS search performed - refer to search results in eDAN.	3/7/2008	STIC	
Inventor name search performed in PALM and EAST.	3/10/2008	PFO3	

<b>INTERFERENCE SEARCH</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>